## Applicant(s)/Patent Under Reexamination Application/Control No. 10/783,037 JANNICK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3744 Richard L. Leung

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,662,825	09-1997	Bivens et al.	252/67
	В	US-6,660,709 B1	12-2003	Dournel et al.	510/461
	C	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-	,		
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002226839	08-2002	JP	Kaneko et al.	F25B 1/00
	0					
	P					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	·
_	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.